


### Issue Classification

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/877,622	LIU ET AL.	
Examiner	Art Unit	
Jennifer T. Nguyen	2629	

## ISSUE CLASSIFICATION

ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
345		173			345	174				
INTERNATIONAL CLASSIFICATION					178	18.07	19.03			
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Jennifer T. Nguyen 5/9/06 (Assistant Examiner) (Date)	 RICHARD HJERPE SUPERVISORY PATENT EXAMINER TECHNICAL CENTER 2600 (Primary Examiner) (Date) 5/16/06	Total Claims Allowed: 5	
Nicholas Peterson 5/17/06 (Legal Instruments Examiner) (Date)		O.G. Print Claim(s) 1	O.G. Print Fig. 2

[illegible]